

Notice of References Cited		Application/Control No. 10/618,696	Applicant(s)/Patent Under Reexamination WANG ET AL.	
		Examiner Brian Swenson	Art Unit 3618	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,678,843	10-1997	Liu, Chin-Shung	280/655
	B	US-6,250,656 B1	06-2001	Ibarra, Jorge L.	280/87.041
	C	US-6,530,598 B1	03-2003	Kirby, Ronald Lee	280/755
	D	US-4,076,266	02-1978	Krausz, Howard I.	280/87.042
	E	US-D301,157	05-1989	Hess, Stanley C.	D21/423
	F	US-5,330,221	07-1994	Sutton, Steven W.	280/293
	G	US-6,331,012	12-2001	Eisenmann et al.	280/293
	H	US-4,183,547	01-1980	Cohen et al.	280/87.042
	I	US-6,386,562	05-2002	Kuo, Hui Shan	280/87.042
	J	US-6,367,828	04-2002	Mandic, Les	280/87.05
	K	US-4,133,548	01-1979	Smith, Gerald E.	280/87.041
	L	US-6,619,678	09-2003	van Ardenne, Robertus Anthonius Maria	280/87.041
	M	US-3,096,100	07-1963	CLARKE ROBERT E; et. al.	280/261

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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